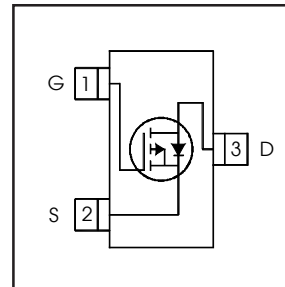


# IRLML6302

HEXFET® Power MOSFET

- Generation V Technology
- Ultra Low On-Resistance
- P-Channel MOSFET
- SOT-23 Footprint
- Low Profile (<1.1mm)
- Available in Tape and Reel
- Fast Switching



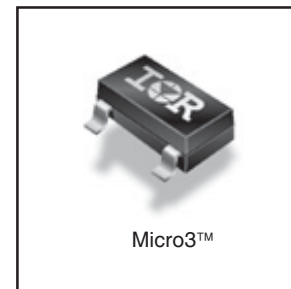
$$V_{DSS} = -20V$$

$$R_{DS(on)} = 0.60\Omega$$

## Description

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

A customized leadframe has been incorporated into the standard SOT-23 package to produce a HEXFET Power MOSFET with the industry's smallest footprint. This package, dubbed the Micro3, is ideal for applications where printed circuit board space is at a premium. The low profile (<1.1mm) of the Micro3 allows it to fit easily into extremely thin application environments such as portable electronics and PCMCIA cards.



## Absolute Maximum Ratings

|                                | Parameter                                  | Max.         | Units |
|--------------------------------|--------------------------------------------|--------------|-------|
| $I_D @ T_A = 25^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ -4.5V$ | -0.78        | A     |
| $I_D @ T_A = 70^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ -4.5V$ | -0.62        |       |
| $I_{DM}$                       | Pulsed Drain Current ①                     | -4.9         |       |
| $P_D @ T_A = 25^\circ\text{C}$ | Power Dissipation                          | 540          | mW    |
|                                | Linear Derating Factor                     | 4.3          | mW/°C |
| $V_{GS}$                       | Gate-to-Source Voltage                     | $\pm 12$     | V     |
| $dv/dt$                        | Peak Diode Recovery $dv/dt$ ②              | -5.0         | V/ns  |
| $T_J, T_{STG}$                 | Junction and Storage Temperature Range     | -55 to + 150 | °C    |

## Thermal Resistance

|                 | Parameter                     | Typ. | Max. | Units |
|-----------------|-------------------------------|------|------|-------|
| $R_{\theta JA}$ | Maximum Junction-to-Ambient ④ | —    | 230  | °C/W  |

Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

|                                 | Parameter                            | Min.  | Typ. | Max. | Units                | Conditions                                                  |
|---------------------------------|--------------------------------------|-------|------|------|----------------------|-------------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | -20   | —    | —    | V                    | $V_{GS} = 0V$ , $I_D = -250\mu A$                           |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —     | -4.9 | —    | mV/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D = -1mA$              |
| $R_{DS(ON)}$                    | Static Drain-to-Source On-Resistance | —     | —    | 0.60 | $\Omega$             | $V_{GS} = -4.5V$ , $I_D = -0.61A$ ③                         |
|                                 |                                      | —     | —    | 0.90 |                      | $V_{GS} = -2.7V$ , $I_D = -0.31A$ ③                         |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | -0.70 | —    | -1.5 | V                    | $V_{DS} = V_{GS}$ , $I_D = -250\mu A$                       |
| $g_{fs}$                        | Forward Transconductance             | 0.56  | —    | —    | S                    | $V_{DS} = -10V$ , $I_D = -0.31A$                            |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —     | —    | -1.0 | $\mu A$              | $V_{DS} = -16V$ , $V_{GS} = 0V$                             |
|                                 |                                      | —     | —    | -25  |                      | $V_{DS} = -16V$ , $V_{GS} = 0V$ , $T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —     | —    | -100 | nA                   | $V_{GS} = -12V$                                             |
|                                 | Gate-to-Source Reverse Leakage       | —     | —    | 100  |                      | $V_{GS} = 12V$                                              |
| $Q_g$                           | Total Gate Charge                    | —     | 2.4  | 3.6  | nC                   | $I_D = -0.61A$                                              |
| $Q_{gs}$                        | Gate-to-Source Charge                | —     | 0.56 | 0.84 |                      | $V_{DS} = -16V$                                             |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —     | 1.0  | 1.5  |                      | $V_{GS} = -4.5V$ , See Fig. 6 and 9 ③                       |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —     | 13   | —    | ns                   | $V_{DD} = -10V$                                             |
| $t_r$                           | Rise Time                            | —     | 18   | —    |                      | $I_D = -0.61A$                                              |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —     | 22   | —    |                      | $R_G = 6.2\Omega$                                           |
| $t_f$                           | Fall Time                            | —     | 22   | —    |                      | $R_D = 16\Omega$ , See Fig. 10 ③                            |
| $C_{iss}$                       | Input Capacitance                    | —     | 97   | —    | pF                   | $V_{GS} = 0V$                                               |
| $C_{oss}$                       | Output Capacitance                   | —     | 53   | —    |                      | $V_{DS} = -15V$                                             |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —     | 28   | —    |                      | $f = 1.0MHz$ , See Fig. 5                                   |

## Source-Drain Ratings and Characteristics

|          | Parameter                              | Min. | Typ. | Max.  | Units | Conditions                                                     |
|----------|----------------------------------------|------|------|-------|-------|----------------------------------------------------------------|
| $I_S$    | Continuous Source Current (Body Diode) | —    | —    | -0.54 | A     | MOSFET symbol showing the integral reverse p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —    | —    | -4.9  |       |                                                                |
| $V_{SD}$ | Diode Forward Voltage                  | —    | —    | -1.2  | V     | $T_J = 25^\circ\text{C}$ , $I_S = -0.61A$ , $V_{GS} = 0V$ ③    |
| $t_{rr}$ | Reverse Recovery Time                  | —    | 35   | 53    | ns    | $T_J = 25^\circ\text{C}$ , $I_F = -0.61A$                      |
| $Q_{rr}$ | Reverse Recovery Charge                | —    | 26   | 39    | nC    | $di/dt = 100A/\mu s$ ③                                         |

## Notes:

① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )

③ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .②  $I_{SD} \leq -0.61A$ ,  $di/dt \leq 76A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ\text{C}$ ④ Surface mounted on FR-4 board,  $t \leq 5sec$ .

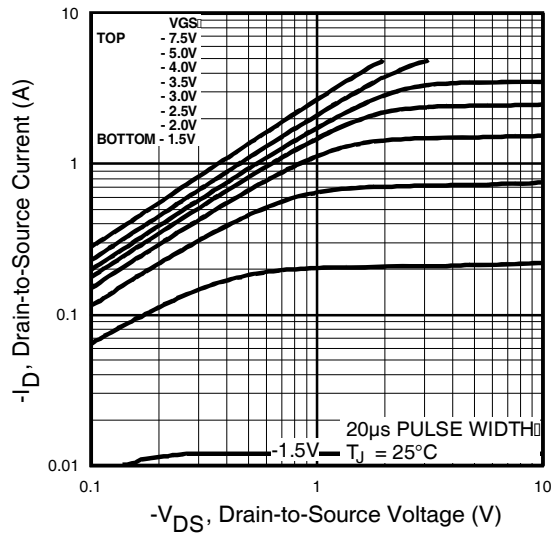


Fig 1. Typical Output Characteristics

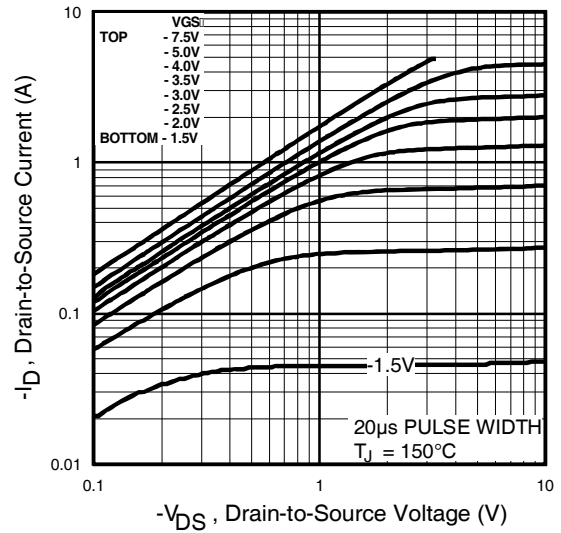


Fig 2. Typical Output Characteristics

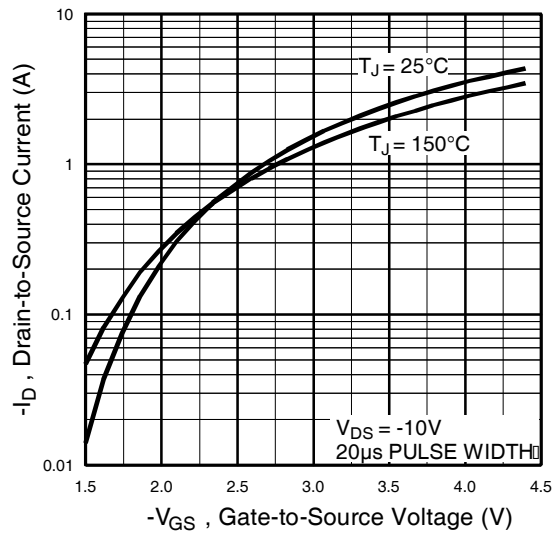


Fig 3. Typical Transfer Characteristics

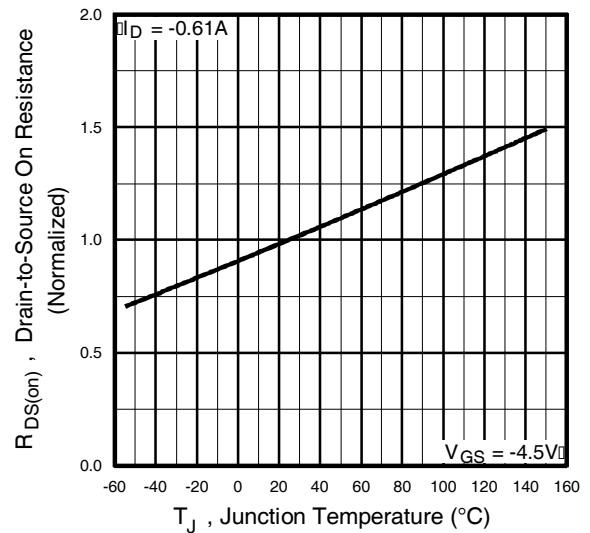
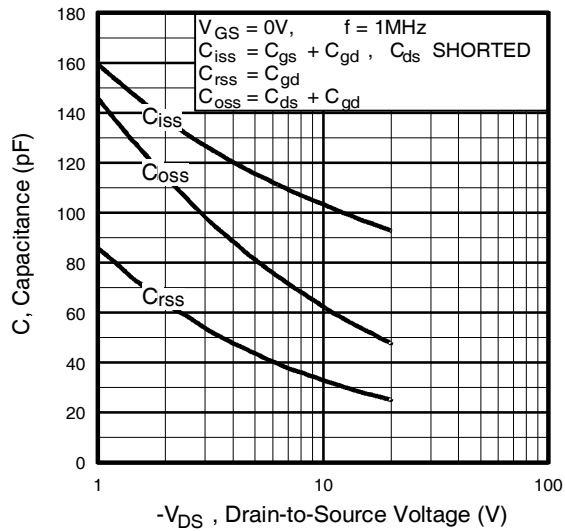
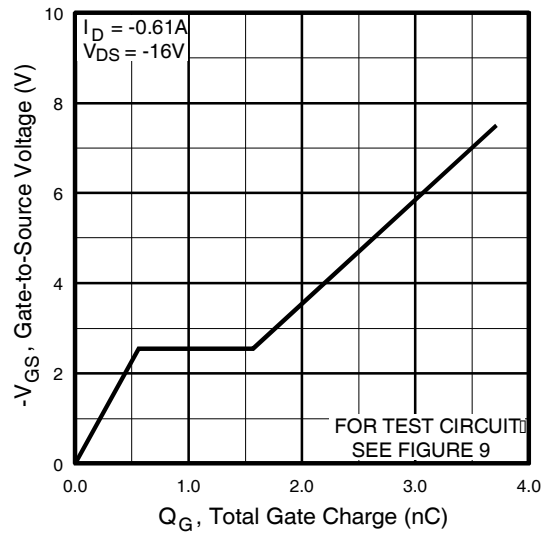


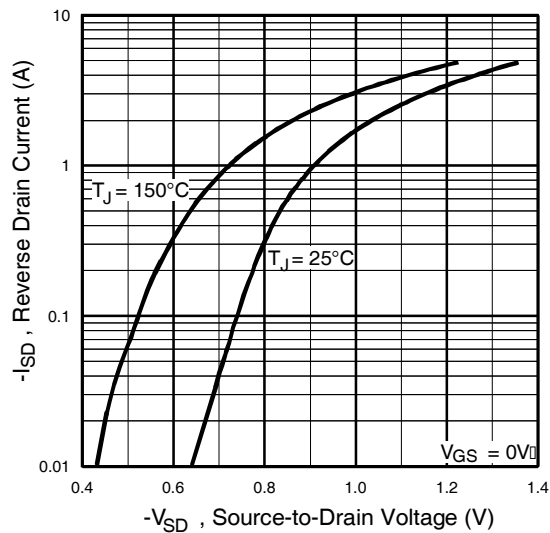
Fig 4. Normalized On-Resistance  
Vs. Temperature



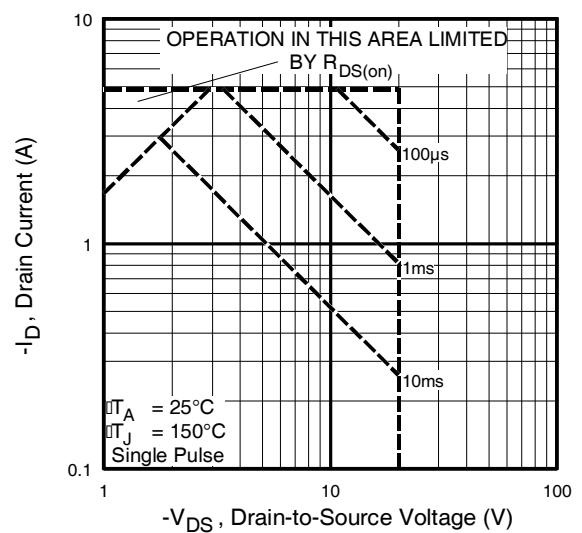
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



**Fig 7.** Typical Source-Drain Diode Forward Voltage



**Fig 8.** Maximum Safe Operating Area

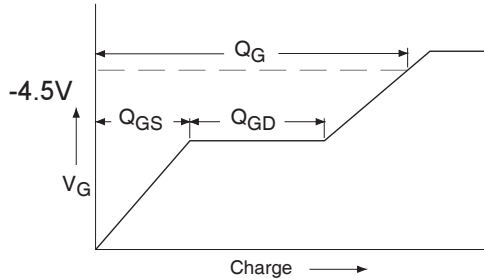


Fig 9a. Basic Gate Charge Waveform

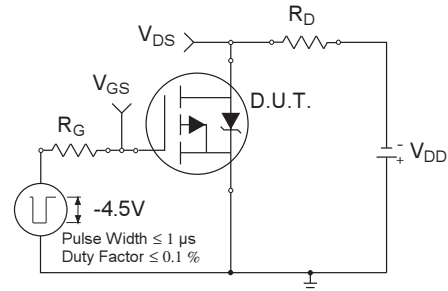


Fig 10a. Switching Time Test Circuit

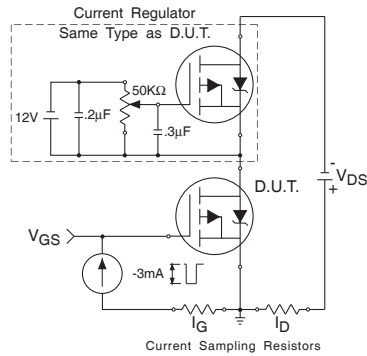


Fig 9b. Gate Charge Test Circuit

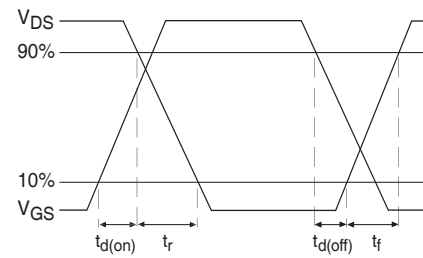


Fig 10b. Switching Time Waveforms

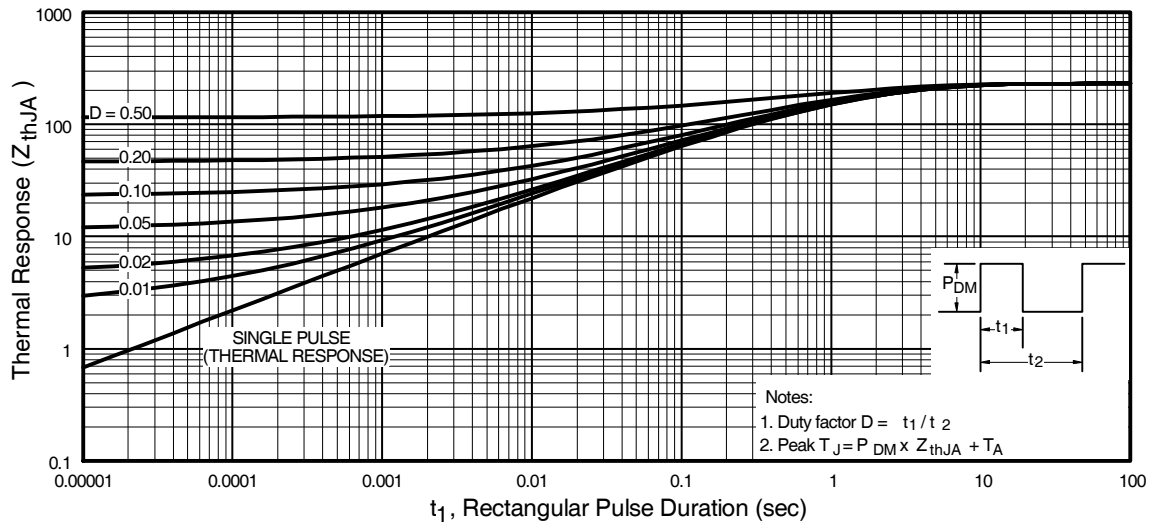
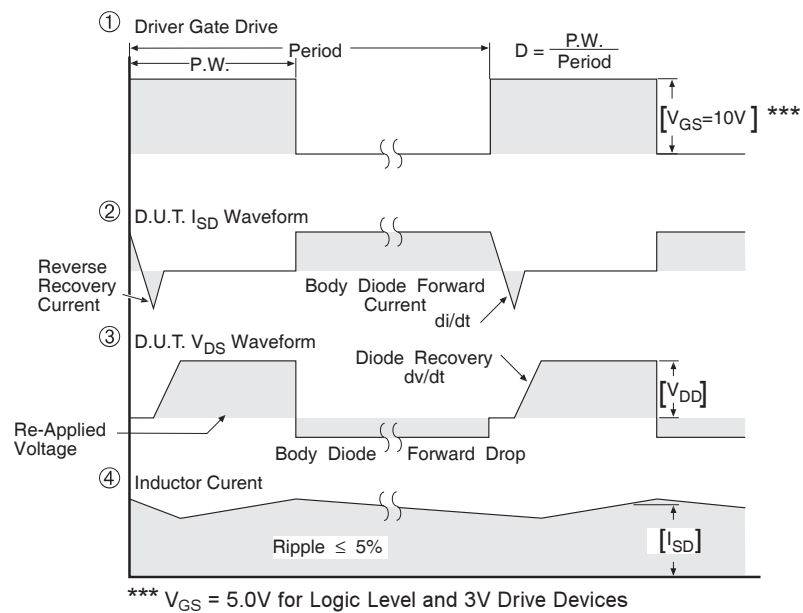
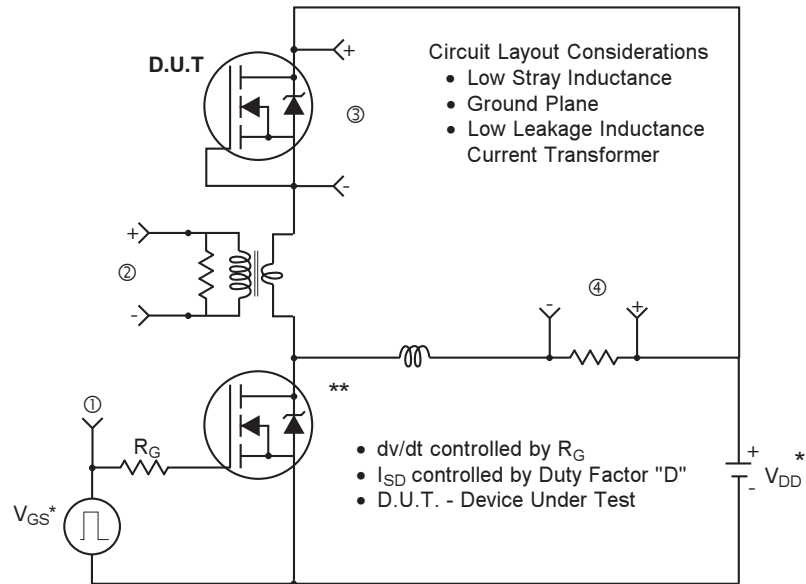


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

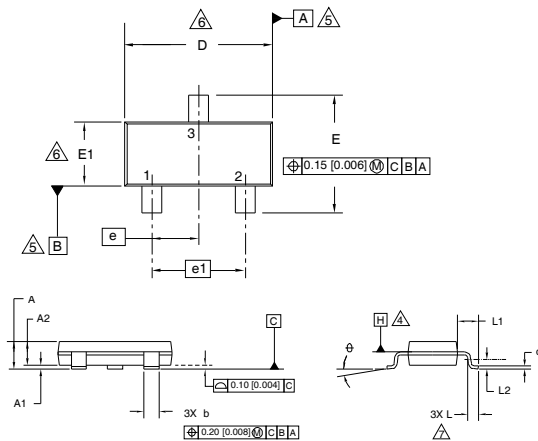
## Peak Diode Recovery $dv/dt$ Test Circuit



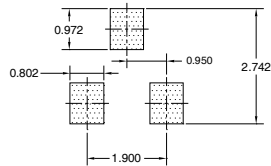
**Fig 13. For P-Channel HEXFETS**

## Micro3 (SOT-23) (Lead-Free) Package Outline

Dimensions are shown in millimeters (inches)



### Recommended Footprint



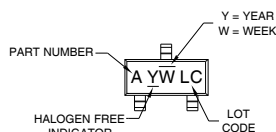
| DIMENSIONS |             |      |        |       |
|------------|-------------|------|--------|-------|
| SYMBOL     | MILLIMETERS |      | INCHES |       |
|            | MIN         | MAX  | MIN    | MAX   |
| A          | 0.89        | 1.12 | 0.035  | 0.044 |
| A1         | 0.01        | 0.10 | 0.0004 | 0.004 |
| A2         | 0.88        | 1.02 | 0.035  | 0.040 |
| b          | 0.30        | 0.50 | 0.012  | 0.020 |
| c          | 0.08        | 0.20 | 0.003  | 0.008 |
| D          | 2.80        | 3.04 | 0.110  | 0.120 |
| E          | 2.10        | 2.64 | 0.083  | 0.104 |
| E1         | 1.20        | 1.40 | 0.047  | 0.055 |
| e          | 0.95        | BSC  | 0.037  | BSC   |
| e1         | 1.90        | BSC  | 0.075  | BSC   |
| L          | 0.40        | 0.60 | 0.016  | 0.024 |
| L1         | 0.54        | REF  | 0.021  | REF   |
| L2         | 0.25        | BSC  | 0.010  | BSC   |
| ⌀          | 0           | 8    | 0      | 8     |

### NOTES:

1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
3. CONTROLLING DIMENSION: MILLIMETER.
4. DATUM PLANE H IS LOCATED AT THE MOLD PARTING LINE.
5. DATUM A AND B TO BE DETERMINED AT DATUM PLANE H.
6. DIMENSIONS D AND E1 ARE MEASURED AT DATUM PLANE H. DIMENSIONS DOES NOT INCLUDE MOLD PROTRUSIONS OR INTERLEAD FLASH. MOLD PROTRUSIONS OR INTERLEAD FLASH SHALL NOT EXCEED 0.25 MM (0.010 INCH) PER SIDE.
7. DIMENSION L IS THE LEAD LENGTH FOR SOLDERING TO A SUBSTRATE.
8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-236 AB.

## Micro3 (SOT-23 / TO-236AB) Part Marking Information

### Micro3 / SOT-23 Package Marking



### PART NUMBER CODE REFERENCE:

A = IRLML2402  
B = IRLML2803  
C = IRLML2402  
D = IRLML5103  
E = IRLML6402  
F = IRLML6401  
G = IRLML2502  
H = IRLML5203

Note: A line above the work week  
(as shown here) indicates Lead-free

W = (1-26) IF PRECEDED BY LAST DIGIT OF CALENDAR YEAR

| YEAR | Y | WORK WEEK | W |
|------|---|-----------|---|
| 2001 | 1 | 01        | A |
| 2002 | 2 | 02        | B |
| 2003 | 3 | 03        | C |
| 2004 | 4 | 04        | D |
| 2005 | 5 |           |   |
| 2006 | 6 |           |   |
| 2007 | 7 |           |   |
| 2008 | 8 |           |   |
| 2009 | 9 |           |   |
| 2010 | 0 | 24        | X |
|      |   | 25        | Y |
|      |   | 26        | Z |

W = (27-52) IF PRECEDED BY A LETTER

| YEAR | Y | WORK WEEK | W |
|------|---|-----------|---|
| 2001 | A | 27        | A |
| 2002 | B | 28        | B |
| 2003 | C | 29        | C |
| 2004 | D | 30        | D |
| 2005 | E |           |   |
| 2006 | F |           |   |
| 2007 | G |           |   |
| 2008 | H |           |   |
| 2009 | J |           |   |
| 2010 | K | 50        | X |
|      |   | 51        | Y |
|      |   | 52        | Z |

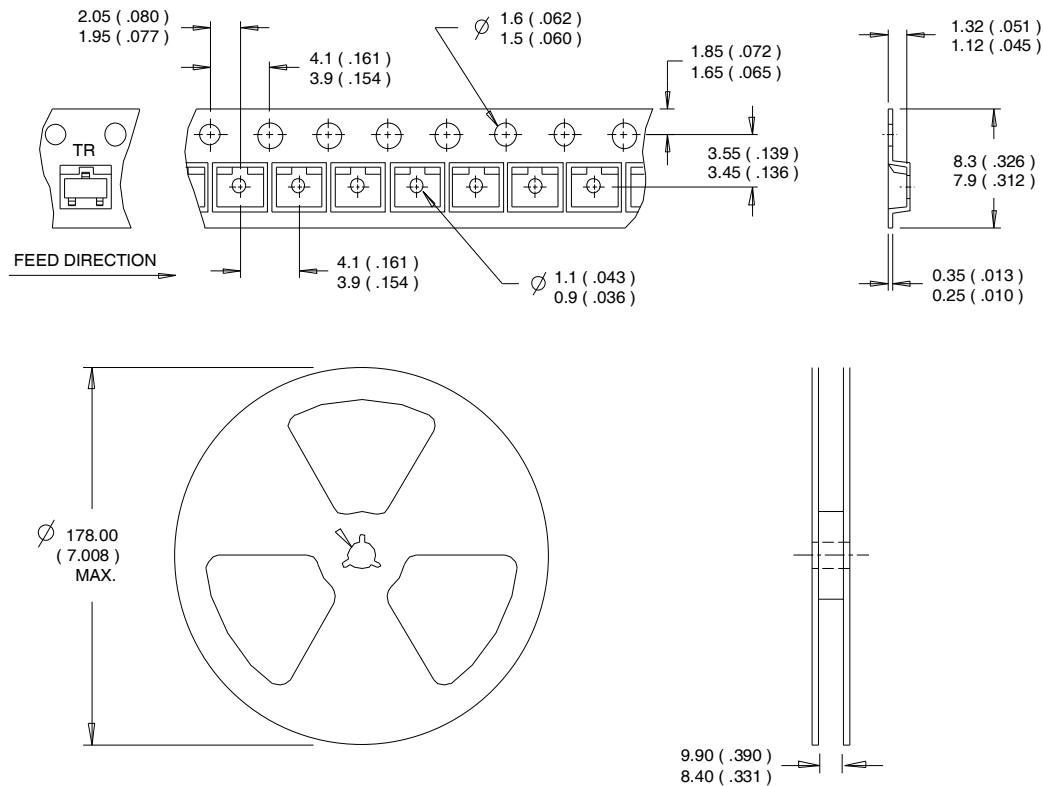
Note: For the most current drawing please refer to IR website at <http://www.irf.com/package>

# IRLML6302

International  
**IR** Rectifier

## Micro3™ Tape & Reel Information

Dimensions are shown in millimeters (inches)



### NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice.

International  
**IR** Rectifier

**IR WORLD HEADQUARTERS:** 101N.Sepulveda Blvd, El Segundo, California 90245, USA Tel: (310) 252-7105  
TAC Fax: (310) 252-7903

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